

Notic of References Cited		Application/Control No. 09/691,219	Applicant(s)/Patent Under Reexamination WEI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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*	N	WO 2002/22684	03-2002	WO	Lee et al.	—
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NON-PATENT DOCUMENTS

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